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(54) **LIQUID CRYSTAL DISPLAY DEVICE AND INSPECTING METHOD OF BONDING STATE BETWEEN LIQUID CRYSTAL DISPLAY PANEL AND DRIVE IC**

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(57) **ABSTRACT**

An LCD device includes a pixel part, formed on a substrate, where a plurality of gate lines and data lines are arranged perpendicular to each other and a plurality of pixels are formed. A terminal has active pads formed on a substrate which communicate a signal to respective ones of the gate lines and data lines of the pixel part. The terminal also has dummy pads formed adjacent to the active pads a transparent material is adjacent or over the dummy pads so as to check a pressed state of conductive balls. A drive IC having a terminal with pads electrically connected one-to-one to the pads of active pads formed on the substrate through the conductive balls, so s to supply a gate signal and/or a data signal to the respective gate line and/or data line.

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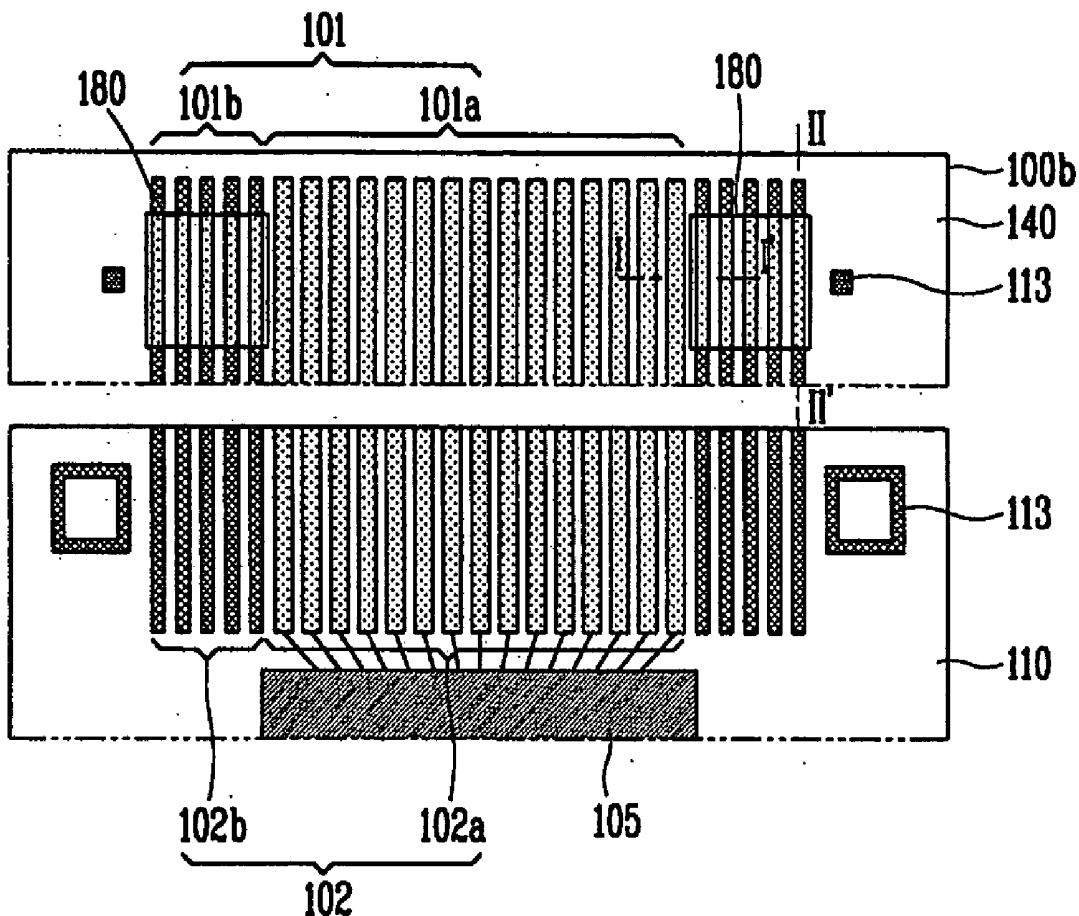


FIG. 3

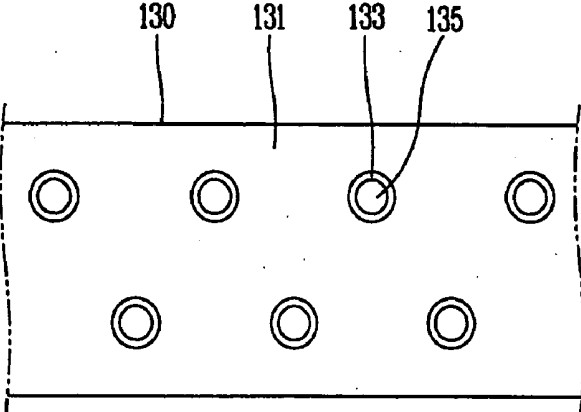


FIG. 4

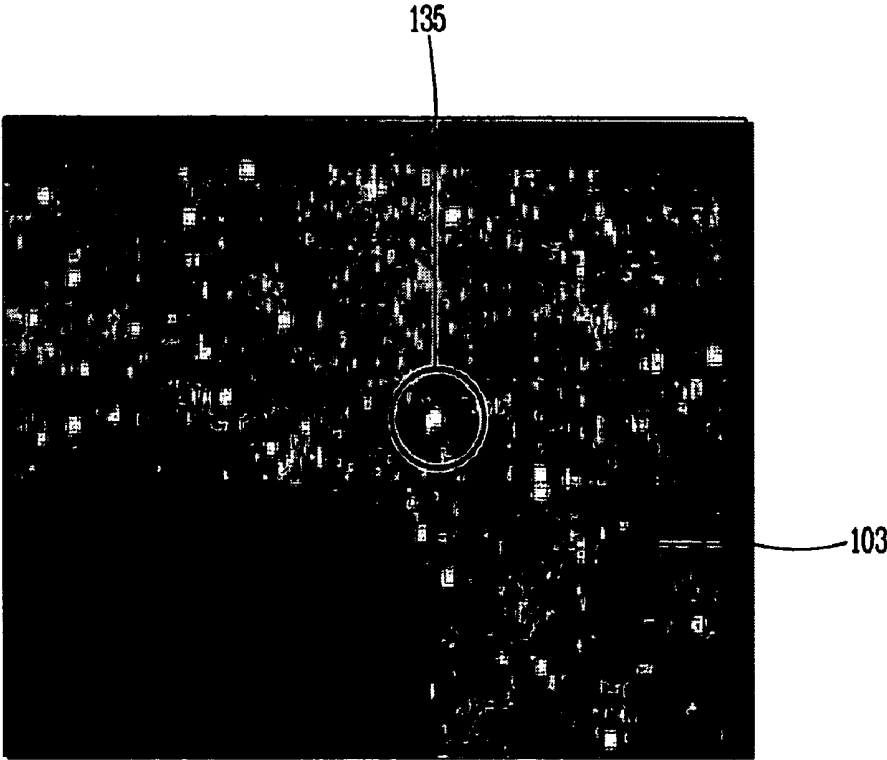


FIG. 5

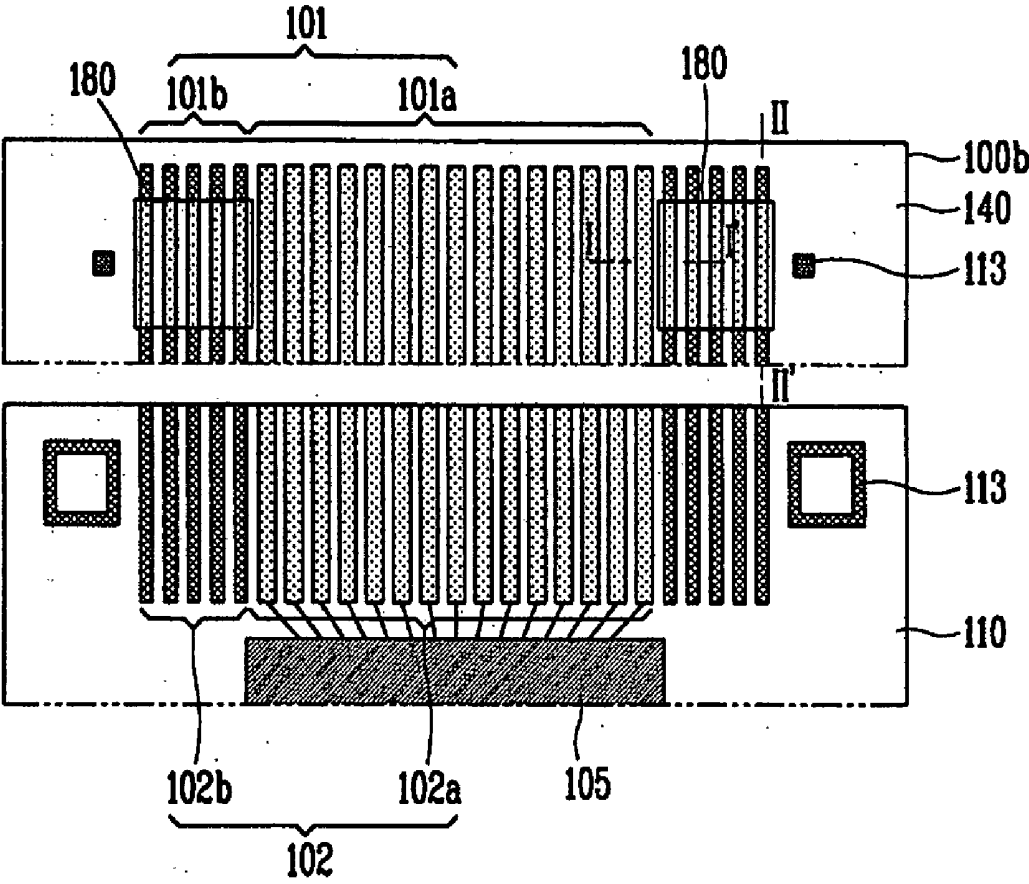


FIG. 6A

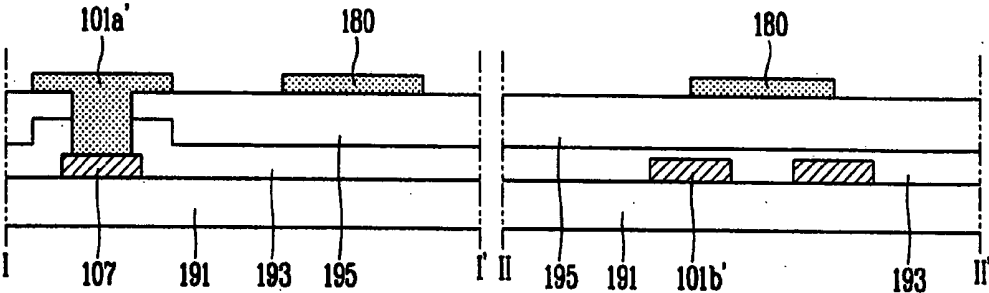
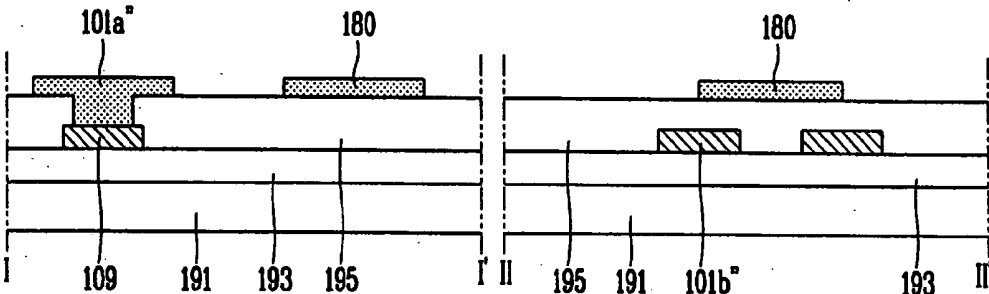


FIG. 6B



**LIQUID CRYSTAL DISPLAY DEVICE AND
INSPECTING METHOD OF BONDING STATE
BETWEEN LIQUID CRYSTAL DISPLAY PANEL
AND DRIVE IC**

[0001] The present application claims, under 35 U.S.C. § 119, the benefit of Korean Patent Application No. 2003-78772 filed Nov. 7, 2003, the entire contents of which are herein fully incorporated by reference.

BACKGROUND OF THE INVENTION

[0002] 1. Field of the Invention

[0003] The present invention relates to a liquid crystal display (LCD) device. More particularly, the present invention related to a method of inspecting a bonding state between a liquid crystal display panel and a drive IC and a structure enabling easy checking of a pressed state of conduct balls of anisotropic conductive film electrically connecting a pad part and a drive IC of a liquid crystal panel.

[0004] 2. Description of the Background Art

[0005] Liquid crystal displays (LCDs) are becoming lighter and thinner, they can operate with relatively low power consumption, and their picture quality continues to improve with enhancements of liquid crystal materials and development of fine pixel processing techniques. As such, LCDs have a wide variety of applications and their use continues to expand.

[0006] An LCD can be divided into a liquid crystal panel and a drive IC. The liquid crystal panel includes liquid crystal cells arranged in a matrix form between two sheets of glass substrates (namely, an upper glass and a lower glass), and switching devices (namely, a TFT array) for switching signals supplied to the liquid crystal cells. The drive IC is mounted on a printed circuit board (PCB) and drives the liquid crystal panel.

[0007] A TCP (Tape Carrier Package) is used to transfer a signal between the liquid crystal panel and the PCB. The TCP is directly attached to the lower glass and the printed circuit board by using a conductive resin such as an anisotropic conductive film (ACF) or the like. In this case, the ACF includes conductive balls having conductivity.

[0008] When the TCP is pressed with a certain pressure so as to be attached to an attachment portion (namely, a contact portion between the TCP and the lower glass or between the TCP and the PCB), the conductive balls in the ACF provides conductivity between the two attached surfaces. In this respect, however, when the conductive balls are pressed, if they fail to be pressed adequately to a state suitable for signal transmission, a distortion occurs in signal transmissions.

[0009] In a related art, in order to monitor the pressed state of the conductive balls, a measurement unit is used, or the pressed state is visually checked by the naked eye by using pressurization paper. Thus, the expense is increased according to employing the measurement unit, and/or the fabrication process is delayed due to the additional process of checking the state of the conductive balls by using the pressurization paper.

SUMMARY OF THE INVENTION

[0010] Therefore, an object of the present invention is to provide a liquid crystal display (LCD) device and a method

for easily inspecting a pressed state of conductive balls in an ACF when connecting a pad part (gate pad and data pad) of an LCD device and a TCP by using the ACF.

[0011] To achieve these and other advantages in accordance with the present invention, as embodied and broadly described herein, there is provided an LCD device including: a substrate; a pixel part formed on the substrate; a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines; a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines; a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines; a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal; and a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal, wherein a first portion of the substrate, proximate the at least one first dummy pad, is formed of a transparent material, and wherein a second portion of the substrate, proximate the at least one second dummy pad, is formed of a transparent material.

[0012] An other aspect of the present invention, there is also provided an LCD device including: a substrate; a pixel part formed on the substrate a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines; a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines; a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines; a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal; a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal; a drive IC having a plurality of signal pads for connection with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal, wherein a first portion of the drive IC, proximate a first side of the signal pads, is formed is of a transparent material, and wherein a second portion of the drive IC, proximate a second side of the signal pads, is formed is of a transparent material.

[0013] An other aspect of the present invention, there is also provided a method of checking a bonding during the assembly of an LCD device including : a substrate; a pixel part formed on the substrate; a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines; a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines; a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines; a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal; a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal; a drive IC having a plurality of signal pads for connection with the plurality of

active pads of the at least one of the gate connection terminal and the data connection terminal, the method comprising the steps of: positioning an anisotropic conductive film between the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal and the plurality of signal pads of the drive IC; aligning the plurality of signal pads of the drive IC with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal; bonding the plurality of signal pads of the drive IC with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal; and inspecting the anisotropic conductive film via at least one transparent portion formed in at least one of the drive IC and the substrate.

[0014] The foregoing and other objects, features, aspects and advantages of the present invention will become more apparent from the following detailed description of the present invention when taken in conjunction with the accompanying drawings.

BRIEF DESCRIPTION OF THE DRAWINGS

[0015] The accompanying drawings, which are included to provide a further understanding of the invention and are incorporated in and constitute a part of this specification, illustrate embodiments of the invention and together with the description serve to explain the principles of the invention.

[0016] In the drawings:

[0017] FIG. 1 shows an LCD device, in accordance with the present invention;

[0018] FIG. 2 shows one embodiment of a pad part, in accordance with the present invention;

[0019] FIG. 3 shows an anisotropic conductive film;

[0020] FIG. 4 shows a pressed state of conductive balls of the anisotropic conductive film observed through a monitoring window;

[0021] FIG. 5 shows another embodiment of the pad part, in accordance with the present invention; and

[0022] FIGS. 6A and 6B are cross sectional views taken along lines I-I' and II-II' of FIG. 5.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

[0023] FIG. 1 shows a schematic plane structure of an LCD in accordance with the present invention, and FIG. 2 shows a schematic structure of a pad part formed on a thin film transistor substrate of FIG. 1.

[0024] As shown, the LCD device includes a liquid crystal panel 100 including a color filter substrate 110a and a thin film transistor substrate 100b. The LCD device also includes IC 105 for driving the liquid crystal panel 100.

[0025] A liquid crystal layer is formed between the two substrates 100a and 100b. A color filter and a black matrix (not shown) are formed on the color filter substrate 100a.

[0026] A plurality of gate lines 107 and a plurality of data lines 109 are arranged perpendicular to each other, vertically and horizontally, to form a pixel part (P) defining a plurality of pixel. A thin film transistor is formed at each pixel.

[0027] A pad part 140 includes a plurality of pads which are connected to one side of respective gate/data lines 107 and 109. The pad part is formed at an edge of the thin film transistor substrate 100b, not covered by the color filter substrate 100a. Matching pads are connected to a TCP 110. The TCP 110 has the drive IC 105 mounted thereon in order to drive the liquid crystal panel 100. The TCP 110 is also connected to a PCB (Printed Circuit Board) 120. The PCB 120 includes various elements and integrated circuits and generates various control signals and data signals to drive the liquid crystal panel 100.

[0028] With reference to FIG. 2, a terminal 101 includes an active pad 101a (or connection terminal) and a dummy pad 101b. Individual pads of the active pad 101a are connected to respective gate lines and/or data lines. The active pad 101a and dummy pad 101b are formed on the pad part 140 of the thin film transistor substrate 100b.

[0029] On the TCP 110, an active pad 102a (or connection terminal) and dummy pad 102b are connected to each terminal of the driving IC 105. The active pad 102a and dummy pad 102b are formed to correspond one-to-one to pads 101a, 101b of the terminal 100 on the pad part 140. Monitoring windows 130 are formed at right and left sides of the dummy pads 101b and 102b.

[0030] The TCP 110 is connected to the pad part 140 of the TFT substrate 100b. The TCP 110 can be connected to the pad part 140 of the substrate 100b by an adhesive anisotropic conductive film (ACF) including conductive particles on the pad part 140, adjusting the terminal 102 of the TCP 110 to the terminal 101 of the pad part 140 to assure proper alignment and then applying an appropriate heat and pressure.

[0031] As shown in FIG. 3, the ACF includes several conductive balls 135 covered by an insulating coating film 133 inside the anisotropic film 131.

[0032] After the ACF is attached to the pad part 140, the pads of the terminal 102 of the TCP 110 are arranged to correspond to the pads of the terminal 101 of the substrate 100b, and then heat and pressure are applied. As the conductive balls 135 are pressed, the insulating coating films 133 covering the conductive balls 135 are broken which allows the conductive balls 135 to electrically connect the pad terminals on a one-to-one basis.

[0033] In order to make the pads of the terminal 101 of the substrate 100b and the pads of the terminal 102 of the TCP 110 correspond or align with each other, the monitoring windows 130 are positioned at both sides of the terminals 102, 101, more especially at both sides of the dummy pads 101b and 102b and function as an alignment key.

[0034] In bonding the pads of the terminal 102 of the TCP 110 to the liquid crystal panel, if the insulating coating film 133 is not broken due to insufficient pressing of the conductive balls 135, contact resistance between the pads of the terminal 101 and 102 is increased so that signal transmission is deteriorated.

[0035] Thus, in the present invention, the windows 130b formed on the TCP 110 are formed of a transparent material such as indium tin oxide (ITO) or indium zinc oxide (IZO) in order to monitor the pressed state of the conductive balls

135 in bonding. By this arrangement, the bonding state between the liquid crystal panel **100** and the TCP **110** can be checked efficiently.

[0036] FIG. 4 shows a pressed state of conductive balls **135** observed through a monitoring window **130b**. As shown, the pressed state of the conductive balls **135** can be observed through the monitoring window **130b** formed of a transparent material. The monitoring windows **130a** are formed of a translucent material to assist in viewing the conductive balls **135**. The pressed state of the conductive balls **135** is monitored by counting the number of pressed conductive balls **135** as observed through the monitoring window **130b**. Namely, if the number of conductive balls **135** observed through the monitoring window **130b** positioned at both sides of the dummy pad **102b** is different, it is determined that a pressure has not been applied uniformly. For example, if more conductive balls **135** are counted through the right window **130b** than the left window **130b**, it can be seen that more pressure and/or heat was applied to the right side.

[0037] In addition, even though uniform pressure is applied to the pad part **140**, the applied pressure can be less than a pre-set required pressure. In this case, the number of pressed conductive balls **135** measured through the left and right monitoring windows **130b** is compared with the pre-set number, and if the number of the pressed conductive balls **135** is less than the pre-set number, it is determined that an insufficient pressure or heat has been applied and thus the bonding has not been made properly.

[0038] As mentioned above, by forming the monitoring window **130b** of a transparent material and by providing a monitoring window **130b** at both sides of the terminal **102**, the pressed state of the conductive balls **135** can be easily checked.

[0039] However, since the position of the monitoring windows **130b** are not a region where the terminal **102** actually is formed, the checked pressed state of the conductive balls **135** and an actual pressed state of the conductive balls **135** in the terminal **102** can be different. This degrades the reliability of the inspection.

[0040] In order to solve such a problem, in an LCD device of another embodiment of the present invention, a monitoring window **180** for checking a pressed state of the conductive balls **135** is formed above or below the dummy pads **101b** and **102b** adjacent to the active pads **101a** and **101b**, to thereby improve the reliability of the inspection of the conductive balls **135**.

[0041] As shown in FIG. 5, a pad part **140**, to which the plurality of gate lines **107** and the plurality of data lines **109** are connected, includes a plurality of active pads **101a** connected to the active pads **102a** of the TCP **110** and dummy pads **101b**, which are not directly connected to the gate lines and data lines, formed at left and right sides of the active pads **101a**. The pad part **140** has a region formed of a transparent material. The region formed of the transparent material is a monitoring window **180**, through which inspection of the conductive balls **135** is made. The monitoring window **180** can be formed in the TFT substrate **100b** at the dummy pads **101b** or at the dummy pads **102b** of the TCP **110**. A region corresponding or facing to the monitoring window **180** may be formed of a translucent material.

[0042] An alignment key **113** is formed at left and right sides of the dummy pads **101b** and **102b** of the TCP **110** and the substrate **100b**. By making the alignment keys **113** correspond to each other, the terminal **101** and **102** of the substrate **100b** and the TCP **110** will be aligned.

[0043] The dummy pads **101b** and **102b** are not electrically connected to the gate lines and/or the data lines, but they have the same structure as the active pads **101a** and **102a**. Since the dummy pads **101b** and **102b** are positioned adjacent to the active pads **101a** and **102a**, the pressed state of the conductive balls **135** in the region is almost similar to the state at the active pads **101a** and **102a**.

[0044] Therefore, compared to the monitoring window **130** positioned at left and right sides of the dummy pads **101b** and **102b** in the former embodiment (refer to FIG. 2), the pressed state of the conductive balls through the monitoring window **180** formed at portion of the dummy pads **101b** and **102b** provides a more reliable indication of the bonding state of the active pads **101a** and **101b**.

[0045] Also at this time, by comparing the number of pressed conductive balls **135** observed through the monitoring windows **180** disposed at left and right sides of the active pads **101a** and **102a**, the overall uniformly pressed state of the terminals **101** and **103** is determined.

[0046] FIGS. 6A and 6B show sections of I-I' and II-II' of the active pad **101a** and the monitoring window **180** of the gate pad part and the data pad part of FIG. 5.

[0047] First, as shown in FIG. 6A, as for the section of the gate pad part, the gate line **107** and the dummy pad **101b'** are formed on a transparent substrate **191**, on which a gate insulation film **193** and a passivation film **195** are sequentially formed. And then, the gate pad **101a'**, electrically connected with the gate line **107** is formed thereon. The gate pad **101a'** and the monitoring window **180** are formed together on the passivation film **195**. The gate pad **101a'** and the monitoring window **180** are formed of a transparent material such as ITO or IZO.

[0048] As shown in FIG. 6B, as for the section of the data pad part, the gate insulation film **193** is formed on the transparent substrate **191**, on which the data line **109** and the dummy pad **101b''** are formed. And then, a passivation film **195** is formed at an upper surface of the data line **109** and the gate insulation film **193**.

[0049] On the passivation film **195**, there are formed the data pad **101a''**, which is electrically connected with the data line **109**, and the monitoring window **180**. The data pad **101a''** and the monitoring window **180** are formed of a transparent material such as ITO or IZO.

[0050] As afore-mentioned, the present invention provides a liquid crystal display wherein a pressed state of the conductive balls can be easily checked via monitoring windows at the pad part. The monitoring windows can be formed either at the TCP or at the liquid crystal panel. By forming the monitoring windows at a portion of the dummy pads, the reliability of judging a conductive state of the conductive balls at the active pads can be improved.

[0051] As so far described, the LCD display device and its inspecting method of a bonding state between a liquid crystal display panel and a drive IC of the present invention have the following advantages.

[0052] In fabricating an LCD device, when bonding is performed for signal connection with the drive IC, it is easy to inspect whether their electric connection has been made properly. In particular, by forming the monitoring window, formed of a transparent material, at the dummy pad of the drive IC, a pressed state of conductive balls can be easily observed and thus a reliable inspection can be made.

[0053] As the present invention may be embodied in several forms without departing from the spirit or essential characteristics thereof, it should also be understood that the above-described embodiments are not limited by any of the details of the foregoing description, unless otherwise specified, but rather should be construed broadly within its spirit and scope as defined in the appended claims, and therefore all changes and modifications that fall within the metes and bounds of the claims, or equivalence of such metes and bounds are therefore intended to be embraced by the appended claims.

What is claimed is:

1. An LCD device comprising:
 - a substrate;
 - a pixel part formed on the substrate a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines;
 - a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines;
 - a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines;
 - a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal; and
 - a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal,
 wherein a first portion of the substrate, proximate the at least one first dummy pad, is formed of a transparent material, and
 - wherein a second portion of the substrate, proximate the at least one second dummy pad, is formed of a transparent material.
2. The LCD device of claim 1, wherein the transparent material is indium tin oxide (ITO) or indium zinc oxide (IZO).
3. The LCD device of claim 1, wherein the first portion of the substrate is adjacent to a side of the first dummy pad; and
 - wherein the second portion of the substrate formed of a transparent material is adjacent to a side of the second dummy pad.
4. The LCD device of claim 1, wherein the first portion of the substrate is above or below the first dummy pad; and
 - wherein the second portion of the substrate is above or below the second dummy pad.

5. The LCD device of claim 1, further comprising:
 - a drive IC having a plurality of signal pads for connection with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.
6. The LCD device of claim 5, wherein portions of the drive IC, which overlay the first and second portions of the substrate formed of a transparent material, are formed of a opaque material.
7. The LCD device of claim 5, wherein the drive IC is mounted on a tape carrier package(TCP).
8. The LCD device of claim 7, further comprising:
 - an alignment key having first portions formed on the TCP and second portions formed on the substrate to permit initial accurate alignment of the plurality of signal pads with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.
9. The LCD device of claim 5, further comprising:
 - an anisotropic conductive film connecting the plurality of signal pads to the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.
10. The LCD device of claim 9, wherein the anisotropic conductive film includes a plurality of conductive balls.
11. The LCD device of claim 1, wherein the first dummy pad is not connected to a gate line or a data line, and the second dummy pad is not connected to a gate line or a data line.
12. An LCD device comprising:
 - a substrate;
 - a pixel part formed on the substrate
 - a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines;
 - a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines;
 - a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines;
 - a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal;
 - a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal;
 - a drive IC having a plurality of signal pads for connection with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal,
 - wherein a first portion of the drive IC, proximate a first side of the signal pads, is formed is of a transparent material, and
 - wherein a second portion of the drive IC, proximate a second side of the signal pads, is formed is of a transparent material.

13. The LCD device of claim 12, wherein the transparent material is indium tin oxide (ITO) or indium zinc oxide (IZO).

14. The LCD device of claim 12, wherein the first portion of the drive IC will overlay to a side of the first dummy pad when plurality of signal pads are connected with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal; and

wherein the second portion of the drive IC will overlay to a side of the second dummy pad when plurality of signal pads are connected with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.

15. The LCD device of claim 12, wherein the first portion of the drive IC will directly overlay the first dummy pad when plurality of signal pads are connected with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal; and

wherein the second portion of the drive will directly overlay the second dummy pad when plurality of signal pads are connected with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.

16. The LCD device of claim 12, wherein portions of the substrate, which overlay the first and second portions of the drive IC formed of an opaque material.

17. The LCD device of claim 12, wherein the drive IC is mounted on a tape carrier package (TCP).

18. The LCD device of claim 17, further comprising:

an alignment key having first portions formed on said TCP and second portions formed on said substrate to permit initial accurate alignment of said plurality of signal pads with said plurality of active pads of said at least one of said gate connection terminal and said data connection terminal.

19. The LCD device of claim 12, further comprising:

an anisotropic conductive film connecting the plurality of signal pads to the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.

20. The LCD device of claim 19, wherein the anisotropic conductive film includes a plurality of conductive balls.

21. The LCD device of claim 12, wherein the first dummy pad is not connected to a gate line or a data line, and the second dummy pad is not connected to a gate line or a data line.

22. A method of checking a bonding during the assembly of an LCD device comprising:

a substrate;

a pixel part formed on the substrate

a plurality of pixels formed on the pixel part and connected to a plurality of gate lines and plurality of data lines;

a plurality of active gate pads, forming a gate connection terminal on the substrate, the plurality of active gate pads being connected to respective ones of the plurality of gate lines;

a plurality of active data pads, forming a data connection terminal on the substrate, the plurality of data pads being connected to respective ones of the plurality of data lines;

a first dummy pad formed on a first side of at least one of the gate connection terminal and the data connection terminal;

a second dummy pad formed on a second side of the at least one of the gate connection terminal and the data connection terminal;

a drive IC having a plurality of signal pads for connection with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal,

the method comprising the steps of:

positioning an anisotropic conductive film between the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal and the plurality of signal pads of the drive IC;

aligning the plurality of signal pads of the drive IC with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal;

bonding the plurality of signal pads of the drive IC with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal; and

inspecting the anisotropic conductive film via at least one transparent portion formed in at least one of the drive IC and the substrate.

23. The method of claim 22, wherein the aligning step includes using an alignment key having first portions formed on the drive IC and second portions formed on the substrate to permit initial accurate alignment of the plurality of signal pads with the plurality of active pads of the at least one of the gate connection terminal and the data connection terminal.

24. The method of claim 22, wherein the bonding step includes applying pressure and heat to the anisotropic conductive film.

25. The method of claim 22, wherein the inspecting step includes evaluating a number and state of conductive balls in the anisotropic conductive film as viewed through the at least one transparent portion.

26. The method of claim 22, wherein the at least one transparent portion includes a first transparent portion formed in the substrate, proximate at least one first dummy pad, and a second transparent portion formed in the substrate, proximate at least one second dummy pad.

27. The method of claim 22, wherein the at least one transparent portion includes a first transparent portion formed in the substrate, above or below at least one first dummy pad, and a second transparent portion formed in the substrate, above or below at least one second dummy pad.

28. The method of claim 22, wherein the at least one transparent portion includes a first transparent portion formed in the drive IC, to reside proximate at least one first dummy pad, and a second transparent portion formed in the drive IC, to reside proximate at least one second dummy pad.

29. The method of claim 22, wherein the at least one transparent portion includes a first transparent portion formed in the drive IC substrate, to overlay at least one first dummy pad, and a second transparent portion formed in the drive IC, to overlay at least one second dummy pad.

专利名称(译)	液晶显示装置和液晶显示面板与驱动IC之间的粘接状态的检查方法		
公开(公告)号	US20050099565A1	公开(公告)日	2005-05-12
申请号	US10/950500	申请日	2004-09-28
[标]申请(专利权)人(译)	SHIN CHUL SANG KIM DEOK NYOUNG		
申请(专利权)人(译)	SHIN哲桑 KIM DEOK-NYOUNG		
当前申请(专利权)人(译)	LG DISPLAY CO. , LTD.		
[标]发明人	SHIN CHUL SANG KIM DEOK NYOUNG		
发明人	SHIN, CHUL-SANG KIM, DEOK-NYOUNG		
IPC分类号	G02F1/1345 G02F1/13 G02F1/1343		
CPC分类号	G02F1/13452 G02F1/1309		
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其他公开文献	US7403257		
外部链接	Espacenet USPTO		

摘要(译)

LCD装置包括形成在基板上的像素部分，其中多条栅极线和数据线彼此垂直布置，并且形成多个像素。端子具有形成在基板上的有源焊盘，其将信号传送到像素部分的相应的栅极线和数据线。端子还具有与有源焊盘相邻形成的虚设焊盘，透明材料与虚设焊盘相邻或在虚设焊盘上方，以便检查导电球的受压状态。一种驱动IC，具有带有焊盘的端子，所述焊盘通过导电球与形成在基板上的有源焊盘的焊盘一对一地电连接，因此s将栅极信号和/或数据信号提供给相应的栅极线和/或数据信号线。

